

DESCRIPTION

2SC1966 is a silicon NPN epitaxial planar type transistor designed for RF power amplifiers on UHF band mobile radio applications.

FEATURES

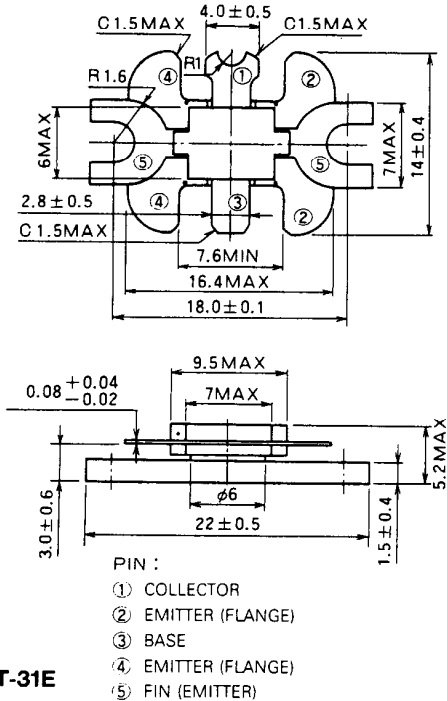
- High power gain: $G_{pe} \geq 7.8\text{dB}$
@ $V_{CC} = 13.5\text{V}$, $P_O = 3\text{W}$, $f = 470\text{MHz}$
- Emitter ballasted construction and gold metallization for high reliability and good performances.
- Low thermal resistance ceramic package with flange.

APPLICATION

1 to 2 watts output power amplifiers in UHF band mobile radio applications.

OUTLINE DRAWING

Dimensions in mm

**T-31E****ABSOLUTE MAXIMUM RATINGS** ($T_C = 25^\circ\text{C}$ unless otherwise specified)

Symbol	Parameter	Conditions	Ratings	Unit
V_{CBO}	Collector to base voltage		35	V
V_{EBO}	Emitter to base voltage		3.5	V
V_{CEO}	Collector to emitter voltage	$R_{BE} = \infty$	17	V
I_C	Collector current		1	A
P_C	Collector dissipation	$T_C = 25^\circ\text{C}$	10	W
T_J	Junction temperature		175	$^\circ\text{C}$
T_{stg}	Storage temperature		-55 to 175	$^\circ\text{C}$
R_{th-c}	Thermal resistance	Junction to case	15	$^\circ\text{C/W}$

Note. Above parameters are guaranteed independently.

ELECTRICAL CHARACTERISTICS ($T_C = 25^\circ\text{C}$ unless otherwise specified)

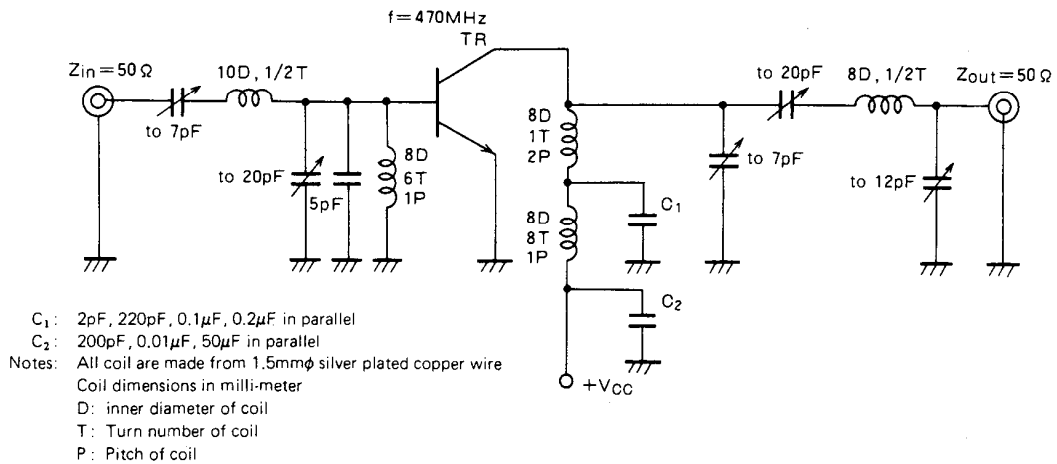
Symbol	Parameter	Test conditions	Limits			Unit
			Min	Typ	Max	
$V_{(BR)EBO}$	Emitter to base breakdown voltage	$I_F = 1\text{mA}$, $I_C = 0$	3.5			V
$V_{(BR)CBO}$	Collector to base breakdown voltage	$I_C = 10\text{mA}$, $I_E = 0$	35			V
$V_{(BR)CEO}$	Collector to emitter breakdown voltage	$I_C = 10\text{mA}$, $R_{BE} = \infty$	17			V
I_{CBO}	Collector cutoff current	$V_{CB} = 15\text{V}$, $I_E = 0$			100	μA
I_{EBO}	Emitter cutoff current	$V_{EB} = 2.5\text{V}$, $I_C = 0$			100	μA
h_{FE}	DC forward current gain *	$V_{CE} = 10\text{V}$, $I_C = 0.1\text{A}$	10	50	180	—
* P_O	Output power	$V_{CC} = 13.5\text{V}$, $P_{in} = 0.5\text{W}$, $f = 470\text{MHz}$	3	3.5		W
η_C	Collector efficiency		50	60		%

Note. * Pulse test, $P_W = 150\mu\text{s}$, duty=5%.

Above parameters, ratings, limits and conditions are subject to change.

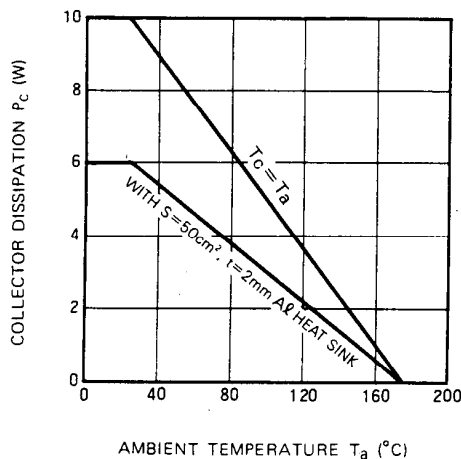
NPN EPITAXIAL PLANAR TYPE

TEST CIRCUIT

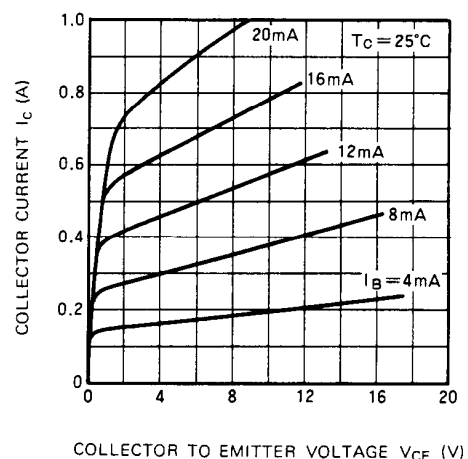


TYPICAL PERFORMANCE DATA

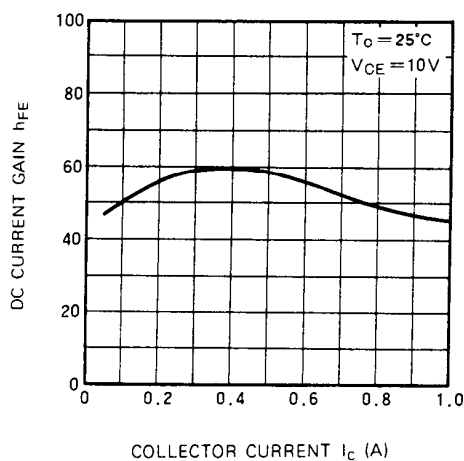
COLLECTOR DISSIPATION VS. AMBIENT TEMPERATURE



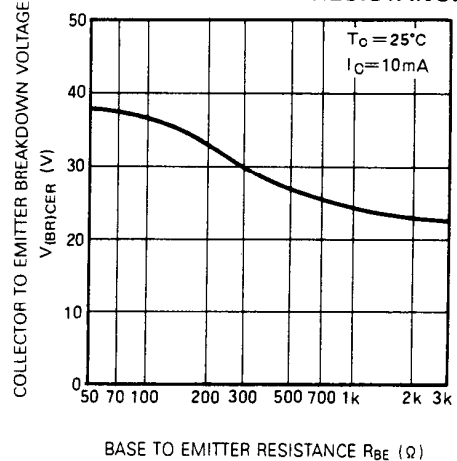
COLLECTOR CURRENT VS. COLLECTOR TO EMITTER VOLTAGE



DC CURRENT GAIN VS. COLLECTOR CURRENT

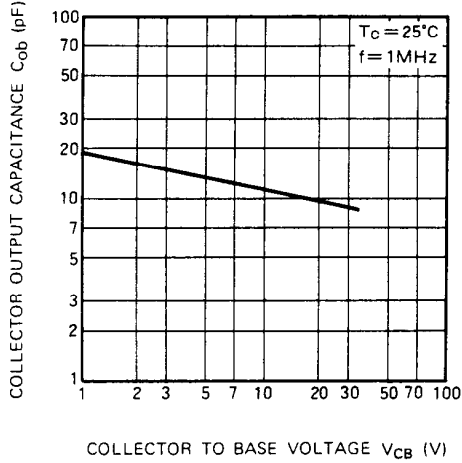


COLLECTOR TO EMITTER BREAKDOWN VOLTAGE VS. BASE TO EMITTER RESISTANCE

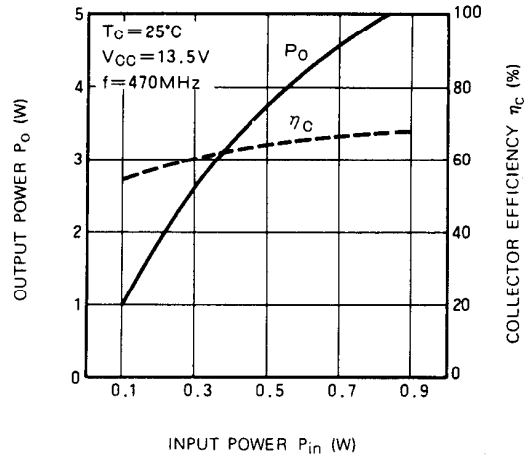


NPN EPITAXIAL PLANAR TYPE

**COLLECTOR OUTPUT CAPACITANCE VS.
COLLECTOR TO BASE VOLTAGE**



**OUTPUT POWER,
COLLECTOR EFFICIENCY
VS. INPUT POWER**



**OUTPUT POWER VS. COLLECTOR
SUPPLY VOLTAGE**

